Searcn Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,670	ONOZAWA ET AL.	
Examiner	Art Unit	
James A. Menefee	2828	

	SEARCHED			
Class	Subclass	Date	Examiner	
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	50.121			
	50.122		4	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search	7/05	<u>م</u>
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